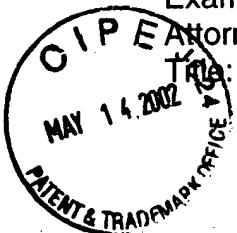


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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. .... 09/332,271  
Filing Date ..... June 11, 1999  
Inventor ..... Klaus Florian Schuegraf et al.  
Assignee ..... Micron Technology, Inc.  
Group Art Unit ..... 2812  
Examiner ..... Ron E. Pompey  
Attorney's Docket No. .... MI22-532  
Title: Methods for Forming Wordlines, Transistor Gates, and Conductive Interconnects,  
and Wordline, Transistor Gate, and Conductive Interconnect Structures



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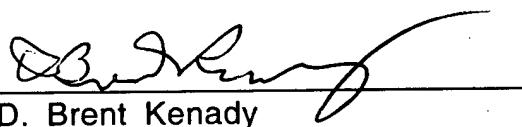
**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**

References -- See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. No admission is made regarding whether any of the submitted references is prior art. Copies of the references are attached.

Respectfully Submitted:

Dated: 5-6-02

  
D. Brent Kenady  
Reg. No. 40,045

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Sheet 1 of 1

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-532		SERIAL NO. 09/332,271		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Klaus Florian Schuegraf				
				FILING DATE June 11, 1999		GROUP 2812		
<b>U.S. PATENT DOCUMENTS</b>								
Examiner Initials <i>GIP</i> <i>MAY 14 1999</i> <i>PATENT &amp; TRADEMARK OFFICE</i>		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
		AA 5,472,896	12/95	Chen et al.	437	44		
		AB 5,393,685	02/95	Yoo et al.	437	44		
		AC 4,833,099	05/89	Woo	437	41		
		AD 5,915,197	06/99	Yamanaka et al.	438	586		
		AE						
		AF						
		AG						
		AH						
		AI						
		AJ						
		AK						
		AL						
<b>FOREIGN PATENT DOCUMENTS</b>								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
		AM						
		AN						
		AO						
		AP						
		AQ						
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AR							
	AS							
	AT							
EXAMINER				DATE CONSIDERED				
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>								